1. INTRODUCTION

High voltage multilayer ceramic chip capacitors are manufactured by using green materials without lead and cadmium. These capacitors feature series connection of multi-layer capacitor units in a MLCC to realize high voltage performance. Reliable performances are built-in through exact formulation of dielectric powders, preparation of conductive paste, advanced automatic manufacturing, and strict quality control to assure excellent control in dielectric thickness, electrode integrity, and electrode-to-termination continuity.

2. FEATURES

- a. Special interior design offers high voltage rating
- b. High reliability and stability.
- c. RoHS & SS-00259 compliant

3. APPLICATIONS

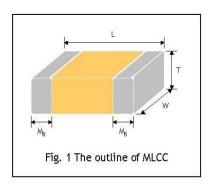
- a. DC to DC converter
- b. High voltage coupling/DC blocking
- c. Back-Lighting inverters.
- d. LAN/WLAN interface.
- e. Modem.
- f. Power supplies.

4.HOW TO ORDER

COG	1206	100	J	3A	N	R
DIELECTRIC	<u>SIZE</u>	CAPACITANCE	TOLERANCE	RATED	TERMINATION	PACKING CODE
NPO=COG	0805	1PF =1R0	A=±0.05PF	VOLTAGE	CODE	B=BULK
X7R = BX	1206	1.5PF = 1R5	B=±0.1PF	3A=1000V	N=NICKEL	R=TAPED ON REEL
	1210	2.2PF =2R2	C=±0.25PF	3D=2000V	BARRIER	
	1812	100PF=101	D=±0.5PF	3F=3000V		
	1825	120PF=121	F=±1%			
	2220	10nF=103	G=±2%			
		100nF= 104	J=±5%			
			K=±10%			
			M=±20%			

5. EXTERNAL DIMENSIONS

Size Inch (mm)	L (mm)	W (mm)	Tmax (mm)	M _B min (mm)
1206 (3216)	3.20±0.20	1.60±0.20	1.80	0.30
1210 (3225)	3.20±0.40	2.50±0.30	2.80	0.30
1808 (4520)	4.50±0.40	2.00±0.20	2.20	0.26
1812 (4532)	4.50±0.40	3.20±0.30	2.80	0.26
1825 (4563)	4.60±0.30	6.30±0.40	3.00	0.26
2220 (5750)	5.70±0.40	5.00±0.40	3.00	0.30
2225 (5763)	5.70±0.40	6.30±0.40	3.00	0.30



6.GENERAL ELECTRICAL DATA

Dielectric		NP0	X7R		
Size	1206, 121	10, 1808, 1812	1206, 1210, 1812, 1808, 1825, 2220, 222		
Rated voltage (WVDC)	1KV,	2KV, 3KV	1KV,	2KV, 3KV	
	1KV	1.5pF ~ 2.2nF	1KV	150pF ~ 56nF	
Capacitance range*	2KV	1.5pF ~ 1.2nF	2KV	150pF ~ 12nF	
	3KV	2.2pF ~ 470pF	3KV	150pF ~ 3.9nF	
Capacitance tolerance	5pF <cap<10pf: c<="" th=""><th>0.1pF), C (±0.25pF) C (±0.25pF), D (±0.5pF)), G (±2%), J (±5%),K (±10%)</th><th colspan="3">J (±5%), K (±10%), M (±20%)</th></cap<10pf:>	0.1pF), C (±0.25pF) C (±0.25pF), D (±0.5pF)), G (±2%), J (±5%),K (±10%)	J (±5%), K (±10%), M (±20%)		
Tan δ*		F: Q≥400+20C 0pF: Q≥1000	≤2.5%		
Insulation resistance at 500Vdc for 60 seconds	≥100GΩ or R•C≥10	000 whichever is smaller	≥10GΩ or R*C≥500Ω-F whichever is smalle		
Operating temperature		-55 to +125	°C		
Temperature coefficient	±30	ppm/°C	±15%		
Termination	Ag/Ni/Sn (lead-free termination)				

^{*} Measured at the condition of 30~70% related humidity.

NP0: Apply 1.0±0.2Vrms, 1.0MHz±10% for Cap≤1000pF and 1.0±0.2Vrms, 1.0kHz±10% for Cap>1000pF, 25°C at ambient temperature

X7R: Apply 1.0±0.2Vrms, 1.0kHz±10%, at 25°C ambient temperature.

[#] Reflow soldering only is recommended if the thickness is thicker than 1.00mm



7.CAPACITANCE RANGE (NP0 Dielectric) 7-1. 1206, 1210, 1808, 1812 Sizes.

	DIELECTRIC	,					NP0	(C0G)					
	SIZE		1206			1210			1808			1812	
RATE	D VOLTAGE (VDC)	1000	2000	3000	1000	2000	3000	1000	2000	3000	1000	2000	3000
	1.5pF (1R5)												
	1.8pF (1R8)												
	2.2pF (2R2)												
	2.7pF (2R7)					7							
	3.3pF (3R3)												
	3.9pF (3R9)					7							
	4.7pF (4R7)												05
	5.6pF (5R6)												
	6.8pF (6R8)												
	8.2pF (8R2)					-				*			
	10pF (100)						97.					· ·	
	12pF (120)												
	15pF (150)												
	18pF (180)												
	22pF (220)												
	27pF (270)												
	33pF (330)												
	39pF (390)												
	47pF (470)				i	2							
	56pF (560)				İ								
	68pF (680)												-
9	82pF (820)												
Capacitance	100pF (101)					7							
cit	120pF (121)												
ba	150pF (151)												
Sa	180pF (181)												
	220pF (221)												
	270pF (271)												
	330pF (331)			- 2									
	390pF (391)												
	470pF (471)												
	560pF (561)												
	680pF (681)												
	820pF (821)												
	1,000pF (102)												
	1,200pF (122)												
	1,500pF (152)												
	1,800pF (182)												
	2,200pF (222)												
	2,700pF (272)												
	3,300pF (332)					V							
	3,900pF (392)												
	4,700pF (472)												
	5,600pF (562)												
	6,800pF (682)								100				
	8,200pF (822)												
	0.010µF (103)								3				

8.CAPACITANCE RANGE (X7R Dielectric)

8.1 1206, 1210, 1808, 1812 Sizes

	DIELECTRIC		X7R								
	SIZE		06		210		1808			1812	
RAT	ED VOLTAGE (VDC)	1000	2000	1000	2000	1000	2000	3000	1000	2000	3000
	100pF (101)							1			
	120pF (121)										
	150pF (151)										
	180pF (181)										
	220pF (221)										
	270pF (271)										
	330pF (331)										
	390pF (391)										
	470pF (471)										
	560pF (561)										
	680pF (681)										
	820pF (821)										
	1,000pF (102)										
	1,200pF (122)										
	1,500pF (152)										
	1,800pF (182)										
S	2,200pF (222)										
an	2,700pF (272)										
E.	3,300pF (332)										
Capacitance	3,900pF (392)										
S	4,700pF (472)										
	5,600pF (562)										
	6,800pF (682)										
	8,200pF (822)										
	0.010µF (103)										
	0.012µF (123)										
	0.015µF (153)										
	0.018µF (183)										
	0.022µF (223)										
	0.027µF (273)										
	0.033µF (333)										
	0.039µF (393)										
	0.047µF (473)										
	0.056µF (563)										
	0.068µF (683)										
	0.082µF (823)										
	0.10µF (104)										



8-2. 2220, 2225 Sizes

	DIELECTRIC					X7R				
	SIZE	1825			2220			2225		
RAT	ED VOLTAGE (VDC)	1000	2000	3000	1000	2000	3000	1000	2000	3000
	1,000pF (102)									
	1,200pF (122)									
	1,500pF (152)									
	1,800pF (182)									
	2,200pF (222)									
	2,700pF (272)								, c	
	3,300pF (332)									
	3,900pF (392)									
	4,700pF (472)									
	5,600pF (562)									
9	6,800pF (682)									
and	8,200pF (822)									
Capacitance	0.010µF (103)									
ab	0.012µF (123)									
O	0.015µF (153)									
	0.018µF (183)									
	0.022µF (223)									
	0.027µF (273)									
	0.033µF (333)									
	0.039µF (393)									
	0.047µF (473)									
	0.056µF (563)									
	0.068µF (683)									
	0.082µF (823)									
	0.10µF (104)					,				



9.RELIABILITY TEST CONDITIONS AND REQUIREMENTS

No.	Item	Test Condition	Requirements
1.	Visual and		* No remarkable defect.
	Mechanical		* Dimensions to conform to individual specification sheet.
2.	Capacitance	Class I: (NP0)	* Shall not exceed the limits given in the detailed spec.
3.	Q/ D.F.	Cap≤1000pF, 1.0±0.2Vrms, 1MHz±10%	NP0: Cap≥30pF, Q≥1000; Cap<30pF, Q≥400+20C
	(Dissipation	Cap>1000pF, 1.0±0.2Vrms, 1KHz±10%	X7R: ≤2.5%
	Factor)	Class II: (X7R)	
		1.0±0.2Vrms, 1kHz±10%	
4.	Temperature	With no electrical load.	
	Coefficient	T.C. Operating Temp	T.C. Capacitance Change
		NP0 -55~125°C at 25°C	NP0 Within ±30ppm/°C
		X7R -55~125°C at 25°C	X7R Within ±15%
5.	Insulation	* To apply voltage at 500VDC for 60 sec.	Class I (NP0) : ≥100GΩ or RxC≥1000Ω-F whichever is smaller.
	Resistance	(30) 66 (30)	Class II (X7R) : ≥10GΩ or RxC≥500Ω-F whichever is smaller.
6.	Dielectric	* To apply voltage:	* No evidence of damage or flashover during test.
	Strength	1.2 times of U _R	The state of the s
	- VI - V	* Duration: 1 to 5 sec.	
			The state of the s
1.	Solderability	* Solder temperature: 245±5°C	75% min. coverage of all metalized area.
8.	Resistance	* Dipping time: 5±0.5 sec. * Solder temperature: 260±5°C	* No remarkable damage.
The second	to Soldering	* Dipping time: 10±1 sec	* Cap change:
	Heat	* Preheating: 120 to 150°C for 1 minute before	NP0: within ±2.5% or ±0.25pF whichever is larger.
		immerse the capacitor in a eutectic solder.	X7R: within ±7.5%
		* Before initial measurement (Class II only): Perform	* 25% max. leaching on each edge.
		150+0/-10°C for 1 hr and then set for 48±4 hrs at room temp.	
		* Measurement to be made after keeping at room	
		temp. for 24±2hrs (Class I) or 48±4 hrs (Class II).	
9.	Temperature	* Conduct the five cycles according to the	* No remarkable damage.
	Cycle	temperatures and time.	* Cap change:
		Step Temp. (°C) Time (min.)	NP0: within ±2.5% or ±0.25pF whichever is larger. X7R: within ±15%
		1 Min. operating temp. +0/-3 30±3 2 Room temp. 2~3	
		3 Max. operating temp. +3/-0 30±3	* Q/D.F.: NP0: ≤2.0 × Initial requirement
		4 Room temp. 2~3	X7R: ≤1.5 x Initial requirement
		* Before initial measurement (Class II only): Perform	*I.R.≥ 0.25 × initial requirement
		150+0/-10°C for 1 hr and then set for 48±4 hrs at	1.11.2 0.25 X Illitial requirement
		room temp.	
		* Measurement to be made after keeping at room temp. for 24±2 hrs (Class I) or 48±4 hrs (Class II).	
10.	Humidity	* Test temp.: 40±2°C	* No remarkable domage
	(Damp Heat)	* Humidity: 90~95% RH	* No remarkable damage. * Cap change:
	Steady State	* Test time: 500+24/-0hrs.	NP0 within ±5% or ±2pF whichever is larger
		* Measurement to be made after keeping at room temp. for 24±2 hrs (Class I) or 48±4 hrs (Class II).	X7R within ±15%
		tomp. for 24-2 ms (Class I) or 4014 ms (Class II).	* Q/D.F Value:
			NP0: Cap≥30pF :Q≥350
			10pF≤Cap<30pF :Q≥275+2.5C
			Cap<10pF :Q≥200+10C
			X7R: ≤7.0%
			*I.R.: ≥1GΩ or RxC≥50Ω-F whichever is smaller.
11.	High	* Test temp.:	* No remarkable damage.
	Temperature Load	NP0, X7R: 125±3°C	* Cap change:
	(Endurance)	* To apply voltage: 120% of rated voltage.	NP0: within ±3% or ±3pF whichever is larger. X7R: within ±20%
	(Endurance)	* Test time: 1000+24/-0 hrs.	The second secon
		* Measurement to be made after keeping at room	* Q/D.F value:
		temp. for 24±2 hrs (Class I) or 48±4 hrs (Class II).	NP0: Cap≥30pF :Q≥350 10pF≤Cap<30pF :Q≥275+2.5C
			Cap<10pF :Q≥200+10C
			X7R: ≤7.0%
			*I.R.: ≥10V, ≥1GΩ or RxC≥50Ω-F whichever is smaller.

9.RELIABILITY TEST CONDITIONS AND REQUIREMENTS (Cont.)

No.	Item	Test Condition	Requirements
	Item Resistance to Flexure of Substrate	* The middle part of substrate shall be pressurized by means of the pressurizing rod at a rate of about 1 mm per second until the deflection becomes 1 mm.	* No remarkable defect. * Dimensions to conform to individual specification sheet.
13.	Adhesive Strength of Termination	* Capacitors mounted on a substrate. A force of 5N applied perpendicular to the place of substrate and parallel the line joining the center of terminations for 10±1 sec. 5N PC Board	* No remarkable damage or removal of the terminations.